




<b>Issue Classification</b> 		<b>Application/Control No.</b> 10537867	<b>Applicant(s)/Patent under Reexamination</b> HAIMER, FRANZ
		<b>Examiner</b> Fulton, Christopher W	<b>Art Unit</b> 2859

ORIGINAL		INTERNATIONAL CLASSIFICATION				
CLASS	SUBCLASS	CLAIMED			NON-CLAIMED	
33	559	G	0	1	B	5 / 20
CROSS REFERENCE(S)						
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					

NONE (Assistant Examiner)	(Date)	<b>Total Claims Allowed:</b> 8	
 (Legal Instruments Examiner)	 Christopher W. Fulton (Primary Examiner)	O.G. Print Claim(s) 1	O.G. Print Figure 1